Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10714654	TAKEKOSHI ET AL.
Examiner	Art Unit
RANDOLPH CHU	2624

SEARCHED					
Class	Subclass	Date	Examiner		
382	100, 128	6/6/2007	ric		
705	2.3	6/6/2007	ric		
715	716	3/20/2008	ric		
707	2	3/20/2008	ric		
382	305	10/23/2008	ric		
358	403, 404	10/23/2008	ric		

SEARCH NOTES				
Search Notes	Date	Examiner		
EAST	6/6/2007	ric		
Inventor Name Search	6/6/2007	ric		
Consult with Wenpeng Chen	6/6/2007	ric		
Updated EAST Search	12/7/2007	ric		
Updated EAST Search	3/20/2008	ric		
STIC Search	10/23/2008	ric		
Updated EAST Search	10/23/2008	ric		
Consult with Andy Johns	10/23/2008	ric		
Updated EAST Search	4/20/2009	ric		

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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